## Young Dong Kim

## List of Publications by Citations

Source: https://exaly.com/author-pdf/4485796/young-dong-kim-publications-by-citations.pdf

Version: 2024-04-03

This document has been generated based on the publications and citations recorded by exaly.com. For the latest version of this publication list, visit the link given above.

The third column is the impact factor (IF) of the journal, and the fourth column is the number of citations of the article.

37
papers

373
citations

9
h-index

g-index

39
ext. papers

2.2
avg, IF

L-index

#	Paper	IF	Citations
37	Bandgap engineering of two-dimensional semiconductor materials. <i>Npj 2D Materials and Applications</i> , <b>2020</b> , 4,	8.8	152
36	Dielectric functions of InxGa1⊠As alloys. <i>Physical Review B</i> , <b>2003</b> , 68,	3.3	39
35	Interband transitions of InAsxSb1⊠ alloy films. <i>Applied Physics Letters</i> , <b>2009</b> , 95, 111902	3.4	23
34	Reinforcement of interfacial adhesion of a coated polymer layer on a cobalt-chromium surface for drug-eluting stents. <i>Langmuir</i> , <b>2014</b> , 30, 8020-8	4	20
33	Dielectric response of AlSb from 0.7 to 5.0 eV determined by in situ ellipsometry. <i>Applied Physics Letters</i> , <b>2009</b> , 94, 231913	3.4	13
32	Optical properties of InxAl1⊠As alloy films. <i>Applied Physics Letters</i> , <b>2008</b> , 92, 151907	3.4	13
31	Model dielectric functions for AlxGa1NAs alloys of arbitrary compositions. <i>Journal of Applied Physics</i> , <b>2008</b> , 104, 013515	2.5	13
30	Temperature Dependence of the Dielectric Function of Monolayer MoSe. <i>Scientific Reports</i> , <b>2018</b> , 8, 31	<b>73</b> 4.9	10
29	Temperature-dependent optical properties of epitaxial CdO thin films determined by spectroscopic ellipsometry and Raman scattering. <i>Journal of Applied Physics</i> , <b>2013</b> , 113, 183515	2.5	9
28	Formation of self-assembled large droplet-epitaxial GaAs islands for the application to reduced reflection. <i>Journal of Applied Physics</i> , <b>2013</b> , 113, 154308	2.5	7
27	Anisotropic behavior of excitons in single-crystal EsnS. AIP Advances, 2020, 10, 105003	1.5	7
26	Dielectric functions and interband transitions of In1\(\mathbb{N}\)AlxSb alloys. Applied Physics Letters, <b>2010</b> , 97, 111	9924	6
25	Optical properties of Co silicides: Experiment and density functional theory. <i>Journal of Applied Physics</i> , <b>2007</b> , 102, 103503	2.5	6
24	Interband transitions and dielectric functions of InGaSb alloys. <i>Applied Physics Letters</i> , <b>2013</b> , 102, 10210	193.4	5
23	Dielectric Functions of CdSe and ZnSe Obtained by Using Vacuum Ultra-Violet Spectroscopic Ellipsometry. <i>Journal of the Korean Physical Society</i> , <b>2007</b> , 50, 806	0.6	5
22	Study of the Interaction Between Biomolecule Monolayers Using Total Internal Reflection Ellipsometry. <i>Journal of the Korean Physical Society</i> , <b>2011</b> , 58, 1031-1034	0.6	5
21	Optical properties of AlAsxSb1⊠ alloys determined by in situ ellipsometry. <i>Applied Physics Letters</i> , <b>2013</b> , 103, 011901	3.4	4

## (2021-2008)

20	Overlayer effects in the critical-point analysis of ellipsometric spectra: Application to InxGa1\( \text{IA}\) alloys. <i>Journal of Applied Physics</i> , <b>2008</b> , 103, 073502	2.5	4
19	Extended Gaussian Filtering for Noise Reduction in Spectral Analysis. <i>Journal of the Korean Physical Society</i> , <b>2020</b> , 77, 819-823	0.6	4
18	Dielectric Functions and Critical Points of GaAsSb Alloys. <i>Journal of the Korean Physical Society</i> , <b>2019</b> , 74, 595-599	0.6	3
17	Optical properties of solution-processed LaAlOx/Si films using spectroscopic ellipsometry. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 04D110	1.3	3
16	Dielectric properties of InAsP alloy thin films and evaluation of direct- and reciprocal-space methods of determining critical-point parameters. <i>Physica Status Solidi (A) Applications and Materials Science</i> , <b>2008</b> , 205, 884-887	1.6	3
15	Quantitative assessment of linear noise-reduction filters for spectroscopy. <i>Optics Express</i> , <b>2020</b> , 28, 389	93 <del>73</del> 38	9 <b>3</b> 3
14	Temperature dependence of the dielectric function and critical points of EsnS from 27 to 350 K. <i>Scientific Reports</i> , <b>2020</b> , 10, 18396	4.9	3
13	Study of the interaction between HSA and oligo-DNA using total internal reflection ellipsometry. Journal of the Korean Physical Society, <b>2012</b> , 60, 1288-1291	0.6	2
12	Surface photoabsorption monitoring of the growth of GaAs and InGaAs at 650°C by MOCVD. <i>Journal of Electronic Materials</i> , <b>1997</b> , 26, 1164-1168	1.9	2
11	Optical Properties of Anisotropic SnSxSe1\(\mathbb{B}\) for Arbitrary Compositions. <i>Journal of the Korean Physical Society</i> , <b>2020</b> , 77, 1178-1182	0.6	2
10	A Systematic Study of Compositionally Dependent Dielectric Tensors of SnSxSe1-x Alloys by Spectroscopic Ellipsometry. <i>Crystals</i> , <b>2021</b> , 11, 548	2.3	2
9	How a Fano Resonance Crosses the Mobility Edge in Quantum Waveguides. <i>Journal of Experimental and Theoretical Physics</i> , <b>2018</b> , 126, 705-711	1	1
8	Lattice constants and optical response of pseudomorph Si-rich SiGe:B. <i>Applied Physics Letters</i> , <b>2013</b> , 103, 202107	3.4	1
7	Dielectric Function and Critical Points of SnS0.52Se0.48 in the Temperature Range from 27 to 350 K. <i>Journal of the Korean Physical Society</i> , <b>2020</b> , 77, 981-986	0.6	1
6	Modeling of the Optical Properties of Monolayer WS2. <i>Journal of the Korean Physical Society</i> , <b>2020</b> , 77, 298-302	0.6	1
5	Maximum-entropy revisited: Optimal filtering of spectra. <i>Journal of Applied Physics</i> , <b>2021</b> , 129, 224902	2.5	1
4	Modeling of the Temperature Dependence of the Dielectric Function of Biaxial EsnS. <i>Journal of the Korean Physical Society</i> , <b>2020</b> , 77, 987-990	0.6	
3	Modeling the temperature dependence of the optical properties of anisotropic SnS0.52Se0.48. Journal of the Korean Physical Society, <b>2021</b> , 78, 269-274	0.6	

Approximated dielectric tensor of the biaxial EsnSe crystal. *Journal of the Korean Physical Society*, **2021**, 78, 297-301

0.6

Azimuthal angle dependent dielectric function of SnS by ellipsometry. *Journal of the Korean Physical Society*, **2022**, 80, 59-62

0.6